

# Silicon Carbide (SiC) MOSFET – EliteSiC, 32 mohm, 650 V, M3S, TOLL NTBL032N065M3S

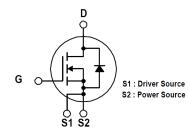
#### **Features**

- Typical  $R_{DS(on)}$ = 32 m $\Omega$  @  $V_{GS}$  = 18 V
- Ultra Low Gate Charge  $(Q_{G(tot)} = 55 \text{ nC})$
- High Speed Switching with Low Capacitance (Coss = 113 pF)
- 100% Avalanche Tested
- This Device is Halide Free and RoHS Compliant with Exemption 7a, Pb–Free 2LI (on second level interconnection)

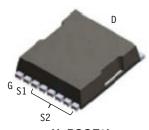
#### **Applications**

- SMPS (Switching Mode Power Supplies)
- Solar Inverters
- UPS (Uninterruptable Power Supplies)
- Energy Storage
- EV Charging Infrastructure

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> TYP	I <sub>D</sub> MAX
650 V	32 mΩ @ 18 V	55 A



**N-Channel MOSFET** 



H-PSOF8L CASE 100DC

#### **MARKING DIAGRAM**



= Assembly Location = Year

WW = Work Week
ZZ = Assembly Lot Code
BL032N065M3S = Specific Device Code

#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 9 of this data sheet.

1

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Value	Unit
Drain-to-Source Voltage		$V_{DSS}$	650	٧
Gate-to-Source Voltage		$V_{GS}$	-8/+22	V
Continuous Drain Current	T <sub>C</sub> = 25°C	I <sub>D</sub>	55	Α
Power Dissipation		P <sub>D</sub>	227	W
Continuous Drain Current	T <sub>C</sub> = 100°C	I <sub>D</sub>	39	Α
Power Dissipation		P <sub>D</sub>	113	W
Pulsed Drain Current (Note 1)	$T_C = 25^{\circ}C, t_p = 100 \ \mu s$	I <sub>DM</sub>	192	Α
Continuous Source-Drain Current (Body Diode)	$T_C = 25^{\circ}C, V_{GS} = -3 \text{ V}$	I <sub>S</sub>	33	Α
	$T_C = 100^{\circ}C, V_{GS} = -3 \text{ V}$		19	
Pulsed Source-Drain Current (Body Diode) (Note 1)	$T_{C} = 25^{\circ}C, V_{GS} = -3 \text{ V}, t_{p} = 100 \mu\text{s}$	I <sub>SM</sub>	173	Α
Single Pulse Avalanche Energy (I <sub>LPK</sub> = 16.7 A, L = 1 mH) (Note 2)			139	mJ
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C
Lead Temperature for Soldering Purposes (1/8" from Case	for 10 s)	TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL CHARACTERISTICS

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case (Note 3)	$R_{\theta JC}$	0.66	°C/W
Thermal Resistance, Junction-to-Ambient (Note 3)	$R_{\theta JA}$	43	°C/W

<sup>3.</sup> The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

#### RECOMMENDED OPERATING CONDITIONS

Parameter	Symbol	Value	Unit
Operation Values of Gate-to-Source Voltage	$V_{GSop}$	-53/+18	V

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

<sup>1.</sup> Repetitive rating, limited by max junction temperature. 2.  $E_{AS}$  of 139 mJ is based on starting  $T_J = 25^{\circ}C$ , L = 1 mH,  $I_{AS} = 16.7$  A,  $V_{DD} = 100$  V,  $V_{GS} = 18$  V.

### **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise stated)

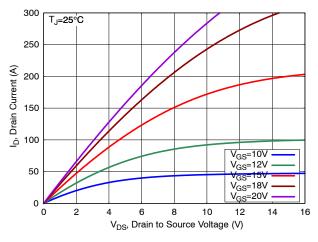
Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	650			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	$\Delta V_{(BR)DSS}/ \Delta T_J$	I <sub>D</sub> = 1 mA, Referenced to 25°C		90		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 650 V, T <sub>J</sub> = 25°C			10	μΑ
		V <sub>DS</sub> = 650 V, T <sub>J</sub> = 175°C (Note 5)			500	μΑ
Gate-to-Source Leakage Current	$I_{GSS}$	$V_{GS} = -8/+22 \text{ V}, V_{DS} = 0 \text{ V}$			±1	μΑ
ON CHARACTERISTICS						
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS} = 18 \text{ V}, I_D = 15 \text{ A}, T_J = 25^{\circ}\text{C}$		32	44	mΩ
		V <sub>GS</sub> = 18 V, I <sub>D</sub> = 15 A, T <sub>J</sub> = 175°C (Note 5)		47		
		V <sub>GS</sub> = 15 V, I <sub>D</sub> = 15 A, T <sub>J</sub> = 25°C		41		
		V <sub>GS</sub> = 15 V, I <sub>D</sub> = 15 A, T <sub>J</sub> = 175°C (Note 5)		52		
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D} = 7.5 \text{ mA}$	2.0	2.9	4.0	V
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 15 A		9.9		S
CHARGES, CAPACITANCES & GATE R	ESISTANCE					
Input Capacitance	C <sub>ISS</sub>	$V_{GS} = 0 \text{ V, } f = 1 \text{ MHz,}$		1396		pF
Output Capacitance	C <sub>OSS</sub>	V <sub>DS</sub> = 400 V (Note 5)		113		1
Reverse Transfer Capacitance	C <sub>RSS</sub>	7		8.9		1
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = -3/18 \text{ V}, V_{DD} = 400 \text{ V},$		55		nC
Gate-to-Source Charge	$Q_{GS}$	I <sub>D</sub> = 15 A (Note 5)		15		]
Gate-to-Drain Charge	$Q_{GD}$			14		
Gate-Resistance	R <sub>G</sub>	f = 1 MHz		5.0		Ω
SWITCHING CHARACTERISTICS						
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS} = -3/18 \text{ V}, V_{DD} = 400 \text{ V},$		8.8		ns
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_D$ = 15 A, R <sub>G</sub> = 4.7 Ω, T <sub>J</sub> = 25°C (Notes 4, 5)		31		
Rise Time	t <sub>r</sub>			12		1
Fall Time	t <sub>f</sub>			9		1
Turn-On Switching Loss	E <sub>ON</sub>			33		μJ
Turn-Off Switching Loss	E <sub>OFF</sub>			16		
Total Switching Loss	E <sub>TOT</sub>			49		1
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS} = -3/18 \text{ V}, V_{DD} = 400 \text{ V},$		7.8		ns
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_D$ = 15 A, R <sub>G</sub> = 4.7 Ω, $T_J$ = 175°C (Notes 4, 5)		37		1
Rise Time	t <sub>r</sub>			12		
Fall Time	t <sub>f</sub>			11		1
Turn-On Switching Loss	E <sub>ON</sub>			31		μJ
Turn-Off Switching Loss	E <sub>OFF</sub>			25		1
Total Switching Loss	E <sub>TOT</sub>			56		1
SOURCE-TO-DRAIN DIODE CHARACT	ERISTICS			-		-
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = -3 \text{ V}, I_{SD} = 15 \text{ A}, T_{J} = 25^{\circ}\text{C}$		4.5	6.0	V
		V <sub>GS</sub> = -3 V, I <sub>SD</sub> = 15 A, T <sub>J</sub> = 175°C		4.2		1

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise stated)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
SOURCE-TO-DRAIN DIODE CHARAC	TERISTICS					
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = -3 \text{ V}, I_S = 15 \text{ A},$ $dI/dt = 1000 \text{ A}/\mu\text{s}, V_{DS} = 400 \text{ V}$		15.5		ns
Charge Time	ta	$di/dt = 1000 \text{ A/µs, } v_{DS} = 400 \text{ V}$ (Note 5)		8.9		1
Discharge Time	t <sub>b</sub>			6.6		1
Reverse Recovery Charge	Q <sub>RR</sub>			72		nC
Reverse Recovery Energy	E <sub>REC</sub>			4.6		μJ
Peak Reverse Recovery Current	I <sub>RRM</sub>	1		9.3		Α

<sup>4.</sup> EON/EOFF result is with body diode.

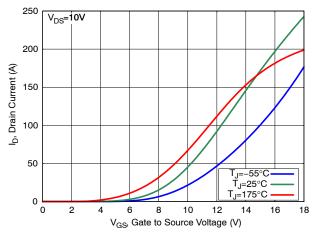
 Defined by design, not subject to production test.
 Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.



300 T<sub>.I=</sub>175°C 250 I<sub>D</sub>, Drain Current (A) 200 150 100 V<sub>GS</sub>=10V V<sub>GS</sub>=12V 50 V<sub>GS</sub>=15V V<sub>GS</sub>=18V  $V_{GS}^{33}=20V$ 0 8 10 14 12 16 V<sub>DS</sub>, Drain to Source Voltage (V)

Figure 1. Output Characteristics

Figure 2. Output Characteristics



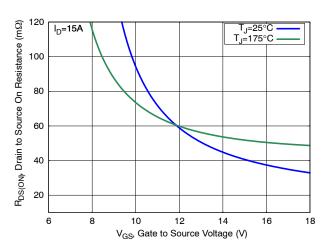
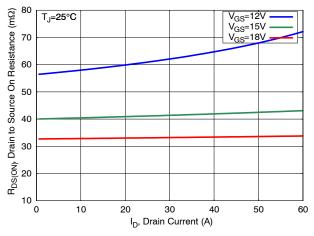


Figure 3. Transfer Characteristics

Figure 4. On-Resistance vs. Gate Voltage



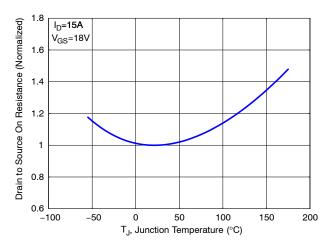


Figure 5. On-Resistance vs. Drain Current

Figure 6. On–Resistance vs. Junction Temperature

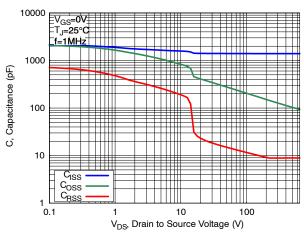


Figure 7. Capacitance Characteristics

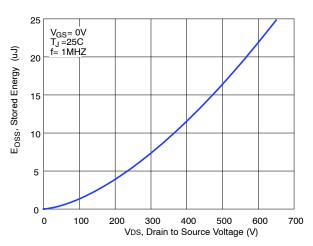


Figure 8. Stored Energy vs. Drain-to-Source Voltage

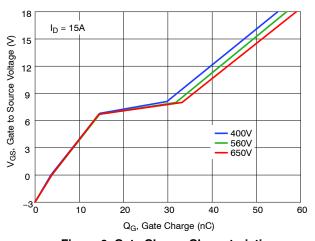


Figure 9. Gate Charge Characteristics

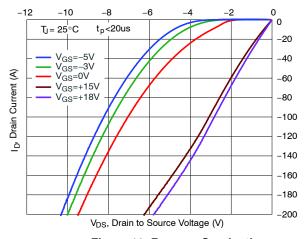


Figure 10. Reverse Conduction Characteristics

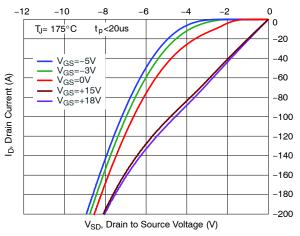


Figure 11. Reverse Conduction Characteristics

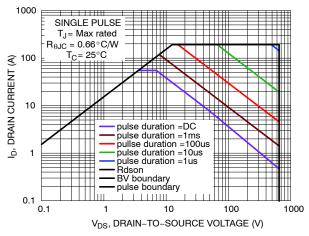
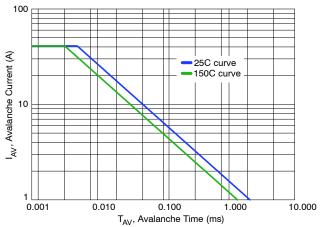


Figure 12. Safe Operating Area



250  $R_{\theta JC} = 0.66 \,{}^{\circ}C/W$ 200 P<sub>D</sub>, Power Dissipation (W) 150 100 50 0 25 50 75 100 125 150 175  $T_C$ , Case Temperature (°C)

Figure 13. Avalanche Current vs. Pulse Time (UIS)

Figure 14. Maximum Power Dissipation vs.

Case Temperature

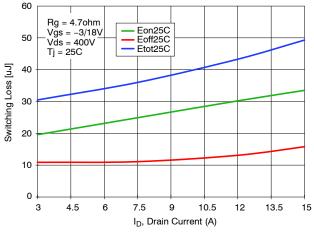


Figure 15. Inductive Switching Loss vs. Drain Current

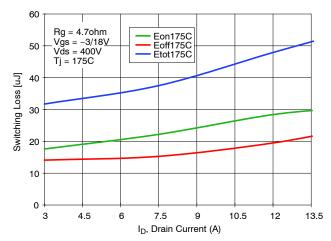
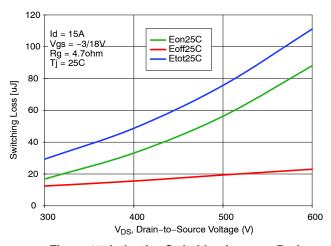


Figure 16. Inductive Switching Loss vs. Drain Current



100 Vgs = -3/18V Vds = 400V Tj = 25C ID = 15A Eon 15A 80 Eoff 15A Etot 15A Switching Loss [uJ] 60 40 20 0 2 3 5 6 9 10 8 RG, Gate Resistance[ $\Omega$ ]

Figure 17. Inductive Switching Loss vs. Drain Voltage

Figure 18. Inductive Switching Loss vs. Gate Resistance

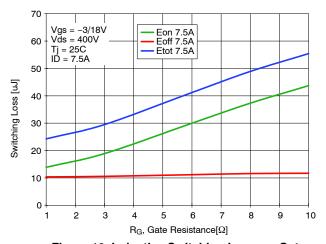


Figure 19. Inductive Switching Loss vs. Gate Resistance

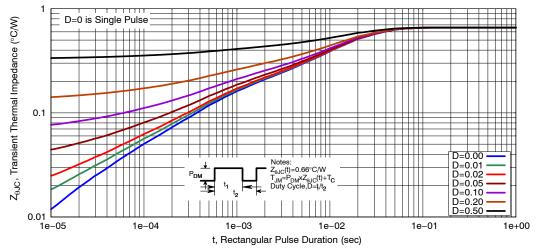


Figure 20. Thermal Response Characteristics

#### **DEVICE ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTBL032N065M3S	H-PSOF8L	2000 / Tape & Reel

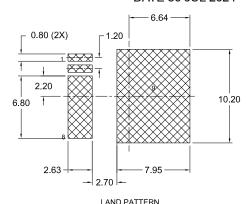
<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



#### CASE 100DC ISSUE D (2x) a ccc В D2 (2x) TERMINAL 1 CORNER INDEX AREA <u></u> E2 (2x) -/7\ SECTION "A-A" SCALE: 2X -(DATUM A) ¬(4X) Ө b (8x) d bbbM C A B D4 (2x) ddd(M) C L2 (8x) ·L1 🙆 **DETAIL "B" TOP VIEW** SCALE: 2X DETAIL "B" SIDE VIEW D1 D5 (2x) D6 D3 (2x) (2x) L3

## H-PSOF8L 9.90x10.38x2.30, 1.20P

#### **DATE 30 JUL 2024**



RECOMMENDATION \*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ONSEMI SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

- NOTES:

  1. PACKAGE STANDARD REFERENCE: JEDEC MO-299, ISSUE B.
- 2. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2018.
- 3. "e" REPRESENTS THE TERMINAL PITCH.
- 4. THIS DIMENSION INCLUDES ENCAPSULATION THICKNESS "A1", AND PACKAGE BODY THICKNESS, BUT DOES NOT INCLUDE ATTACHED FEATURES, e.g., EXTERNAL OR CHIP CAPACITORS. AN INTEGRAL HEATSLUG IS NOT CONSIDERED AS ATTACHED FEATURE. 5. A VISUAL INDEX FEATURE MUST BE LOCATED WITHIN THE HATCHED AREA.
- 6. DIMENSIONS b1,L1,L2 APPLY TO PLATED TERMINALS.
- 7. THE LOCATION AND SIZE OF EJECTOR MARKS ARE OPTIONAL. 8. THE LOCATION AND NUMBER OF FUSED LEADS ARE OPTIONAL.

DIM	MILLIMETERS			
	MIN.	NOM.	MAX.	
Α	2.20	2.30	2.40	
A1	1.70	1.80	1.90	
b	0.70	0.80	0.90	
b1	9.70	9.80	9.90	
b2	0.35	0.45	0.55	
С	0.40	0.50	0.60	
D	10.28	10.38	10.48	
D/2	5.09	5.19	5.29	
D1	10.98	11.08	11.18	
D2	3.20	3.30	3.40	
D3	2.60	2.70	2.80	
D4	4.45	4.55	4.65	
D5	3.20	3.30	3.40	
D6	0.55	0.65	0.75	
E	9.80	9.90	10.00	
E1	7.30	7.40	7.50	
E2	0.30	0.40	0.50	
E3	7.40	7.50	7.60	
E4	8.20	8.30	8.40	

DIM	MII	LIMETE	RS	
DIW	MIN.	NOM.	MAX.	
E5	9.36	9.46	9.56	
E6	1.10	1.20	1.30	
E7	0.15	0.18	0.21	
е		1.20 BSC	;	
e/2		0.60 BSC		
Н	11.58	11.68	11.78	
H/2	5.74	5.84	5.94	
H1	7.15 BSC			
L	1.63	1.73	1.83	
L1	0.60	0.70	0.80	
L2	0.50	0.60	0.70	
L3	0.43	0.53	0.63	
θ		10° REF		
Θ1		10° REF		
aaa	0.20			
bbb	0.25			
CCC	0.20			
ddd	0.20			
eee		0.10		

#### H/2 (DATUM B)-**GENERIC** H1 MARKING DIAGRAM\* **BOTTOM VIEW** AYWWZZ

(3x)

E1 E3 E4 E5

HEAT SLUG TERMINAL

XXXX = Specific Device Code

D/2

Α = Assembly Location

= Year

(DATUM A)

\_ b2 (8x)

/8\

L (8x)

WW = Work Week

= Assembly Lot Code

XXXXXXX XXXXXXX

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

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DESCRIPTION:	H-PSOF8L 9.90x10.38x2.30, 1.20P		PAGE 1 OF 1	

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